PATENT NUMBER ISSUE CLASSIFICATION U.S. REISSUE Patent Application O.G. PUBLICATION DATE REISSUE PATENT DATE SCANNED A.G. 8-14-01 SUBCRASS ART UNIT EXAMINER CONT/PRIOR CLASS APPLICATION NO. 718 2133 .09/871978 TON Makoto Hatakenaka Akira Yamszaki Shigeki Tomishima Tadato Yamagata Semiconductor integrated cifcuit comprising synchronous DRAM core and logic circuit integrated into a single chip and method of testing the synchronous DRAM core (Exr. Initials) ORIGINAL PATENT NUMBER \_ ISSUING CLASSIFICATION **ORIGINAL CROSS REFERENCE(S)** CLASS SUBCLASS SUBCLASS (ONE SUBCLASS PER BLOCK) CLASS INTERNATIONAL CLASSIFICATION 06F 11/00 ġ. 40 Continued on Issue Slip Inside File Jacket TR TERMINAL DRAWINGS **CLAIMS ALLOWED** DISCLAIMER Sheets Drwg. Figs. Drwg. Print Fig. **Total Claims** Print Claim for O.G. 10 15: 5 18 10 NOTICE OF ALLOWANCE MAILED The term of this patent subsequent to\_\_\_\_ has been disclaimed. BEST AVAILABLE COP **DAVID TON** The term of this patent shall not extend beyond the expiration date PRIMARY EXAMINER ISSUE FEE of U.S Patent. No. Amount Due Date Paid Jawal Ton 12/8/01 The terminal months of this patent have been disclaimed. **FINAL SPRE REVIEW ISSUE BATCH NUMBER** (DITTALS) (Legal Instruments Examiner) (Date) The information disclosed herein may be restricted. Unauthorized disclosure may be prohibited by the United States Code Title 35, Sections 122, 181 and 368. Possession outside the U.S. Petent & Trademark Office is restricted to authorized employees and contractions only. Form PTO-2008 (Rev. 8/99) FILED WITH: DISK (CRF) FICHE CD-ROM

Issue Classification

Application No.	Applicant(s)		
09/871,978	HATAKENAKA ET AL.		
Examiner	Art Unit		
David Ton	2133		

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(Assistant Examiner) (Date)				DAVID TON PRIMARY EXAMINER		Total Claims Allowed: 14						
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